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# Build in Biasing Circuit MOS FET IC UHF RF Amplifier



ADE-208-809C (Z) 4th. Edition Mar. 2001

#### **Features**

• Build in Biasing Circuit; To reduce using parts cost & PC board space.

Build in ESD absorbing diode. Withstand up to 200V at C=200pF, Rs=0 conditions.

- Low noise; NF = 1.6 dB typ. at f = 900 MHz
- High gain; PG = 22 dB typ. at f = 900 MHz
- Withstanding to ESD;
- Provide mini mold packages; MPAK-4(SOT-143Rmod)

## **Outline**

#### MPAK-4



- 1. Source
- 2. Gate1
- 3. Gate2
- 4. Drain

Notes: 1. Marking is "BS-".

2. BB502M is individual type number of HITACHI BBFET.

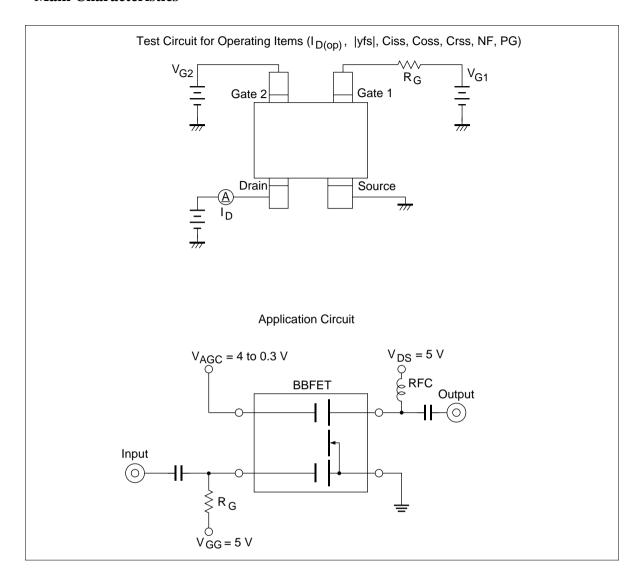
## **Absolute Maximum Ratings** (Ta = 25°C)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V <sub>DS</sub>	6	V	
Gate1 to source voltage	$V_{G1S}$	+6 -0	V	
Gate2 to source voltage	$V_{G2S}$	+6 -0	V	
Drain current	I <sub>D</sub>	20	mA	
Channel power dissipation	Pch	150	mW	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

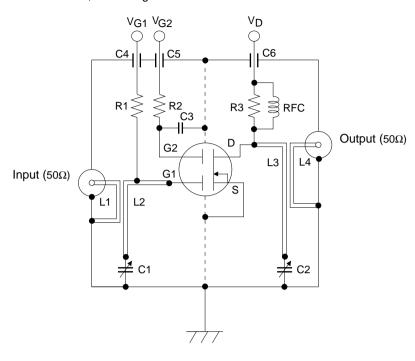
## **Electrical Characteristics** ( $Ta = 25^{\circ}C$ )

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	6	_	_	V	$I_D = 200 \mu A$ $V_{G1S} = V_{G2S} = 0$
Gate1 to source breakdown voltage	$V_{(BR)G1SS}$	+6	_	_	V	$I_{G1} = +10 \mu A$ $V_{G2S} = V_{DS} = 0$
Gate2 to source breakdown voltage	$V_{(BR)G2SS}$	+6	_	_	V	$I_{G2} = +10 \mu A$ $V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff current	I <sub>G1SS</sub>	_	_	+100	nA	$V_{G1S} = +5V$ $V_{G2S} = V_{DS} = 0$
Gate2 to source cutoff current	I <sub>G2SS</sub>	_	_	+100	nA	$V_{G2S} = +5V$ $V_{G1S} = V_{DS} = 0$
Gate1 to source cutoff voltage	$V_{\text{G1S(off)}}$	0.5	0.7	1.0	V	$V_{DS} = 5V, V_{G2S} = 4V$ $I_{D} = 100\mu A$
Gate2 to source cutoff voltage	$V_{\text{G2S(off)}}$	0.5	0.7	1.0	V	$V_{DS} = 5V, V_{G1S} = 5V$ $I_{D} = 100\mu A$
Drain current	I <sub>D(op)</sub>	8	11	14	mA	$V_{DS} = 5V, V_{G1} = 5V$ $V_{G2S} = 4V, R_{G} = 180k\Omega$
Forward transfer admittance	$ y_{fs} $	20	25	30	mS	$V_{DS} = 5V$ , $V_{G1} = 5V$ $V_{G2S} = 4V$ $R_G = 180k\Omega$ , $f = 1kHz$
Input capacitance	C <sub>iss</sub>	1.4	1.7	2.0	pF	$V_{DS} = 5V, V_{G1} = 5V$
Output capacitance	C <sub>oss</sub>	0.7	1.1	1.5	pF	$V_{G2S}$ =4V, $R_{G}$ = 180k $\Omega$
Reverse transfer capacitance	C <sub>rss</sub>	_	0.02	0.05	pF	f = 1MHz
Power gain	PG	17	22	_	dB	$V_{DS} = 5V, V_{G1} = 5V$ $V_{G2S} = 4V, R_{G} = 180k\Omega$
Noise figure	NF	_	1.6	2.2	dB	f = 900MHz

## **Main Characteristics**



#### 900MHz Power Gain, Noise Figure Test Circuit



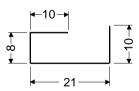
C1, C2: Variable Capacitor (10pF MAX)

C3: Disk Capacitor (1000pF)

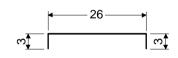
C4 to C6: Air Capacitor (1000pF)

R1:  $180 \text{ k}\Omega$ R2:  $47 \text{ k}\Omega$ R3:  $4.7 \text{ k}\Omega$ 

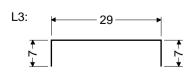
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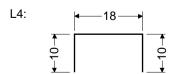


L2:

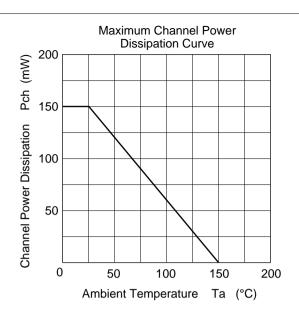


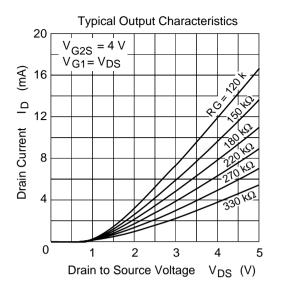
(\$1mm Copper wire)
Unit: mm

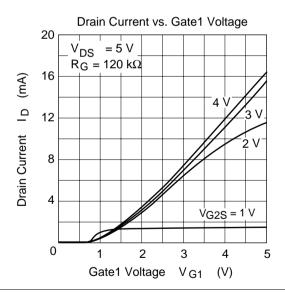


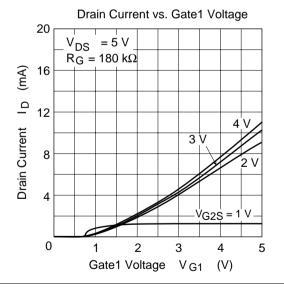


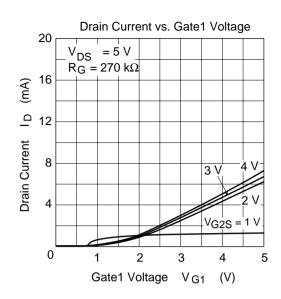
RFC: \$1mm Copper wire with enamel 4turns inside dia 6mm

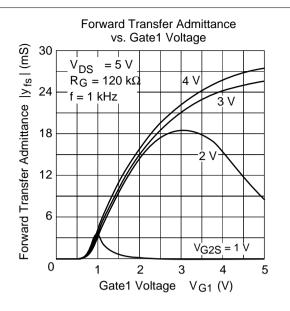


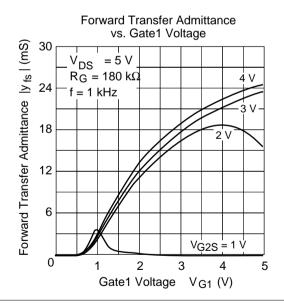


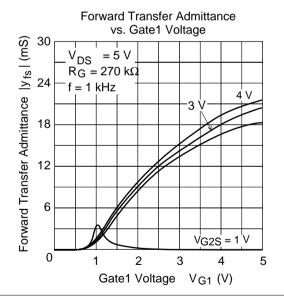


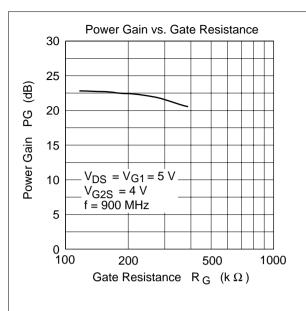


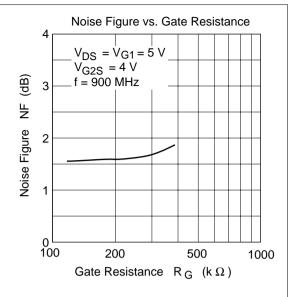


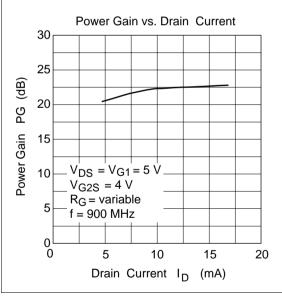


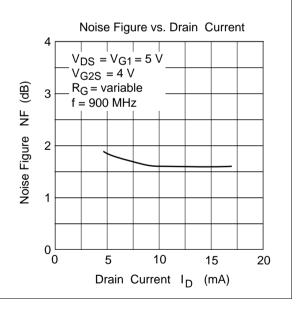


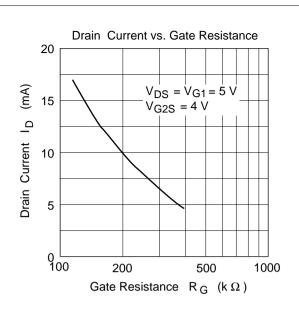


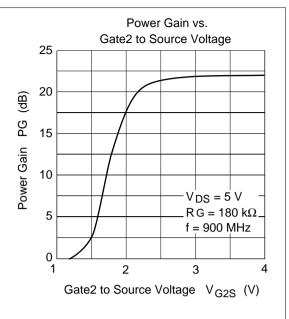


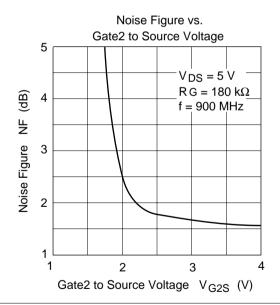


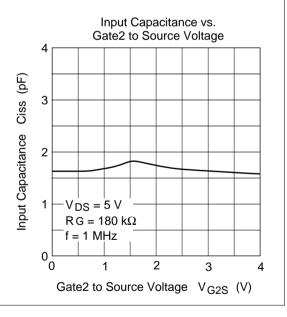


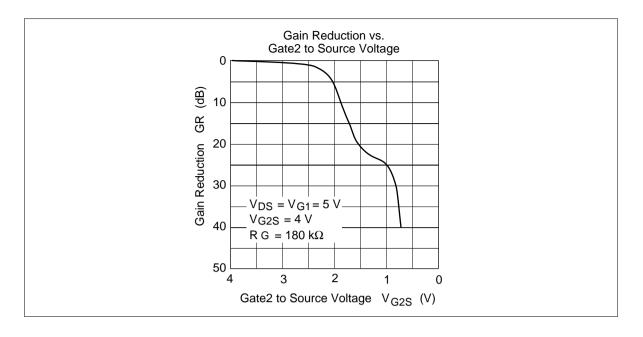




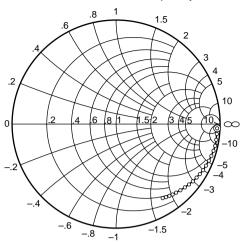








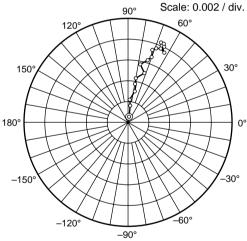
#### S11 Parameter vs. Frequency



Test Condition; V  $_{DS}$  = 5 V , V  $_{G1}$  = 5 V V  $_{G2S}$  = 4 V , R  $_{G}$  = 180 k  $\Omega$  , Zo = 50  $\Omega$ 

50 to 1000 MHz (50 MHz step)

### S12 Parameter vs. Frequency

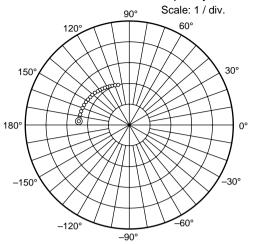


Test Condition: V  $_{DS}$  = 5 V , V  $_{G1}$  = 5 V  $V_{G2S}$  = 4 V , R  $_{G}$  = 180 k  $\Omega$  , Zo = 50  $\Omega$ 

50 to 1000 MHz (50 MHz step)

 $\odot$ 

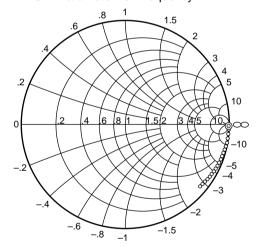
#### S21 Parameter vs. Frequency



Test Condition: V  $_{DS}$  = 5 V , V  $_{G1}$  = 5 V V  $_{G2S}$  = 4 V , R  $_{G}$  = 180 k  $\Omega$  , Zo = 50  $\Omega$ 

50 to 1000 MHz (50 MHz step)

### S22 Parameter vs. Frequency



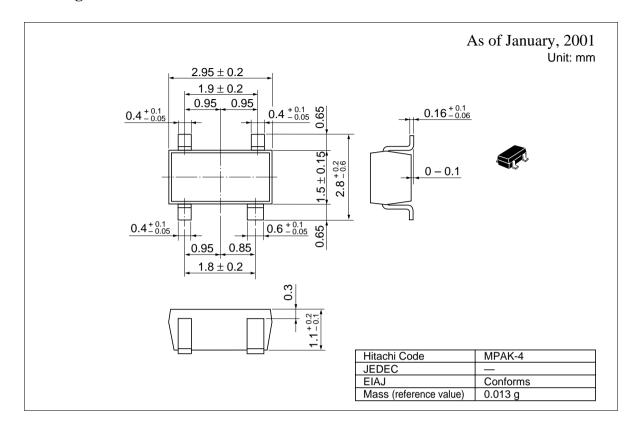
Test Condition: V  $_{DS}$  = 5 V , V  $_{G1}$  = 5 V  $V_{G2S}$  = 4 V , R  $_{G}$  = 180 k  $\Omega$  , Zo = 50  $\Omega$ 

50 to 1000 MHz (50 MHz step)

Sparameter	$(V_{DS} = V_{DS})$	$V_{\rm G1} = 5 \rm V,  V_{\rm G2}$	$V_{G2S} = 4V, R_G =$	$180$ k $\Omega$ , Zo = $50\Omega$ )
------------	---------------------	-------------------------------------	-----------------------	--------------------------------------

	S11 S		S21	S21		S12		S22	
f (MHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
50	0.994	-2.8	2.52	176.2	0.00072	88.6	0.995	-2.2	
100	0.994	<b>−</b> 5.7	2.51	172.4	0.00161	80.9	0.998	-4.0	
150	0.991	-9.2	2.50	168.1	0.00230	86.6	0.997	-6.2	
200	0.985	-12.5	2.47	164.1	0.00297	78.0	0.996	-8.2	
250	0.985	-15.5	2.46	160.0	0.00374	78.9	0.994	-10.2	
300	0.975	-18.7	2.43	156.4	0.00436	80.6	0.992	-12.2	
350	0.969	-22.0	2.40	152.3	0.00507	70.9	0.990	-14.2	
400	0.962	-24.9	2.38	148.6	0.00557	77.3	0.989	-16.3	
450	0.954	-27.7	2.35	144.6	0.00625	72.4	0.987	-18.5	
500	0.945	-30.8	2.31	141.0	0.00663	70.0	0.984	-20.4	
550	0.935	-33.8	2.28	136.7	0.00721	70.5	0.981	-22.4	
600	0.925	-36.6	2.25	133.4	0.00747	68.4	0.978	-24.3	
650	0.918	-39.5	2.21	130.3	0.00761	65.6	0.975	-26.4	
700	0.909	-42.5	2.18	126.1	0.00807	65.6	0.972	-28.3	
750	0.898	-45.0	2.14	122.9	0.00828	67.6	0.969	-30.2	
800	0.887	-47.8	2.09	119.5	0.00801	65.1	0.965	-32.2	
850	0.874	-50.6	2.07	116.0	0.00815	63.6	0.961	-34.2	
900	0.862	-53.0	2.03	112.7	0.00832	65.1	0.958	-36.1	
950	0.855	-55.5	1.99	109.4	0.00738	61.8	0.954	-37.9	
1000	0.845	-58.1	1.95	106.1	0.00802	65.8	0.951	-39.8	

## **Package Dimensions**



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Semiconductor & Integrated Circuits. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

**URL** NorthAmerica http://semiconductor.hitachi.com/ http://www.hitachi-eu.com/hel/ecg Europe Asia http://sicapac.hitachi-asia.com

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#### For further information write to:

Hitachi Semiconductor (America) Inc. 179 East Tasman Drive, San Jose,CA 95134 Tel: <1> (408) 433-1990 Germany Fax: <1>(408) 433-0223 Tel: <49> (89) 9 9180-0

Hitachi Europe GmbH Electronic Components Group Dornacher Straße 3 D-85622 Feldkirchen, Munich Fax: <49> (89) 9 29 30 00

Hitachi Europe Ltd. Electronic Components Group. Whitebrook Park Lower Cookham Road Maidenhead Berkshire SL6 8YA, United Kingdom Tel: <886>-(2)-2718-3666 Tel: <44> (1628) 585000

Fax: <44> (1628) 585160

Hitachi Asia Ltd. Hitachi Tower 16 Collyer Quay #20-00, Singapore 049318 Tel: <65>-538-6533/538-8577 Fax: <65>-538-6933/538-3877 URL: http://www.hitachi.com.sg

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Fax: <886>-(2)-2718-8180 Telex: 23222 HAS-TP URL: http://www.hitachi.com.tw Group III (Electronic Components) 7/F., North Tower, World Finance Centre, Harbour City, Canton Road Tsim Sha Tsui, Kowloon, Hong Kong Tel: <852>-(2)-735-9218

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